Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YONEYAMA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,398,567 B1	06-2002	Nishimura, Takeshi	439/159
	В	US-2004/0014342 A1	01-2004	Yu et al.	439/159
	С	US-2003/0096521	05-2003	Kikuchi et al.	439/159
	D	US-2001/0012712	08-2001	Nishioka, Toru	439/159
	Ε	US-2002/0037658	03-2002	Ozawa, Hiroshi	439/159
	F	US-6,482,020	11-2002	Yeh, Ryan	439/159
	G	US-6,663,403	12-2003	Hsu, Hugh Chi	439/159
	Ή	US-2002/0004327	01-2002	Nishioka, Toru	439/159
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					٠
	Р					·
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

		Water the second
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.